Sear	ch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/541,011	JOSHI ET AL.
Examiner	Art Unit
Edna Wong	1753

	SEARCHED			
Class	Subclass	Date	Examiner	
204	157.15	11/15/2006	EW	
204	157.5	11/15/2006	EW	
204	157.52	11/15/2006	EW	
	"			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Inventor Search	11/15/2006	EW
EAST	11/15/2006	EW
STN .	11/15/2006	EW